

Search Notes

Application/Control No.

10/755,019

Examiner

David Nhu

Applicant(s)/Patent under
Reexamination

NAKAI ET AL.

Art Unit

2818

SEARCHED

Class	Subclass	Date	Examiner
257	288	6/9/2005	
	289, 290		
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	461, 462		
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
SEARCHED IN EAST	6/9/2005	DN